

**Search Notes**

Application/Control No.

10/537,471

Examiner

John S. Chu

Applicant(s)/Patent under  
Reexamination

DWARS ET AL.

Art Unit

1752

**SEARCHED**

Class	Subclass	Date	Examiner
430	175	2/2007	JSC
430	176	↓	↓
430	302	↓	↓

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST SEARCH IN FILE	2/2007	JSC